


<b>Search Notes</b>  	<b>Application/Control No.</b>  10731181	<b>Applicant(s)/Patent Under Reexamination</b>  SINGH ET AL.
	<b>Examiner</b>  Anthony Weier	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner
426	634, 656, 673	6/20/08	AW
updated	previous search	2/13/09	AW

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--